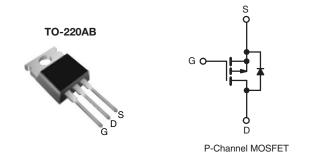


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	- 60				
R _{DS(on)} (Ω)	V _{GS} = - 10 V 0.50				
Q _g (Max.) (nC)	12				
Q _{gs} (nC)	3.8				
Q _{gd} (nC)	5.1				
Configuration	Single				



FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- P-Channel
- 175 °C Operating Temperature
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION			
Package	TO-220AB		
Lead (Pb)-free	IRF9Z14PbF		
Lead (Fb)-life	SiHF9Z14-E3		
SnPb	IRF9Z14		
SIFD	SiHF9Z14		

ABSOLUTE MAXIMUM RATINGS (T_C	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	- 60	V	
Gate-Source Voltage			V _{GS}	± 20	7 v	
Continuous Drain Current	V at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$		- 6.7		
Continuous Drain Current	V _{GS} at - 10 V	T _C = 100 °C	I _D	- 4.7	Α	
Pulsed Drain Current ^a			I _{DM}	- 27		
Linear Derating Factor				0.29	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	140	mJ	
Repetitive Avalanche Current ^a			I _{AR}	- 6.7	Α	
Repetitive Avalanche Energy ^a	E _{AR}	4.3	mJ			
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P _D	43	W	
Peak Diode Recovery dV/dtc	dV/dt	- 4.5	V/ns			
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	00	
Soldering Recommendations (Peak Temperature) for 10 s			<u> </u>	300 ^d	°C	
Mounting Toyaus	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 3.6 mH, R_g = 25 Ω , I_{AS} = 6.7 A (see fig. 12).
- c. $I_{SD} \le$ 6.7 A, $dI/dt \le$ 90 A/µs, $V_{DD} \le V_{DS}$, $T_J \le$ 175 °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	62			
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	R_{thJC}	-	3.5			

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$) V, I _D = - 250 μA	- 60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I _D = - 1 mA	-	- 0.060	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	V _{DS} = V _{GS} , I _D = - 250 μA		-	- 4.0	V
Gate-Source Leakage	I _{GSS}	Vo	V _{GS} = ± 20 V		-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		V _{DS} = -60 V, V _{GS} = 0 V V _{DS} = -48 V, V _{GS} = 0 V, T _J = 150 °C		-	- 100 - 500	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D = - 4.0 A ^b	-	-	0.50	Ω
Forward Transconductance	9 _{fs}	V _{DS} = - 2	25 V, I _D = - 4.0 A ^b	1.4	-	-	S
Dynamic					L	L	l
Input Capacitance	C _{iss}		$V_{GS} = 0 \text{ V},$ $V_{DS} = -25 \text{ V},$ f = 1.0 MHz, see fig. 5		270	-	pF
Output Capacitance	C _{oss}	V _I			170	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.0			31	-	
Total Gate Charge	Qg			-	-	12	
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V	$I_D = -6.7 \text{ A}, V_{DS} = -48 \text{ V},$ see fig. 6 and 13 ^b	-	-	3.8	nC
Gate-Drain Charge	Q _{gd}		occ ng. o and ro	-	-	5.1	
Turn-On Delay Time	t _{d(on)}			-	11	-	
Rise Time	t _r	V _{DD} = - :	V _{DD} = - 30 V, I _D = - 6.7 A,		63	-	ns ns
Turn-Off Delay Time	t _{d(off)}	$R_g = 24~\Omega,~R_D = 4.0~\Omega,~see~fig.~10^b$		-	10	-	
Fall Time	t _f			-	31	-	
Internal Drain Inductance	L_D		6 mm (0.25") from		4.5	-	ъU
Internal Source Inductance	L _S	package and center of die contact		-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	- 6.7	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	- 27	Α
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = -6.7 A, V _{GS} = 0 V ^b		-	-	- 5.5	V
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = -6.7 A, dI/dt = 100 A/μs ^b		-	80	160	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.096	0.19	μC
Forward Turn-On Time	t _{on}	Intrinsic turr	n-on is dominated by L _S and L _D)			L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width $\leq 300~\mu s$; duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

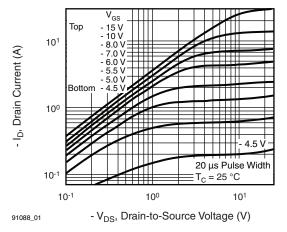


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

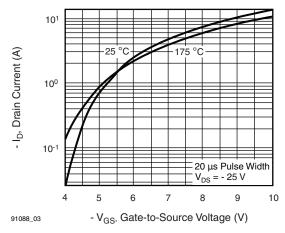


Fig. 3 - Typical Transfer Characteristics

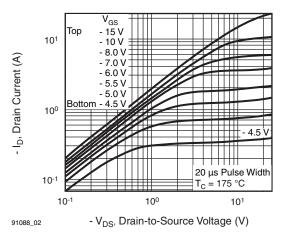


Fig. 2 - Typical Output Characteristics, T_C = 175 $^{\circ}$ C

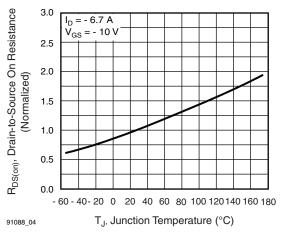


Fig. 4 - Normalized On-Resistance vs. Temperature



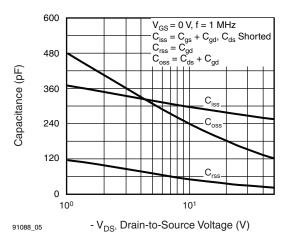


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

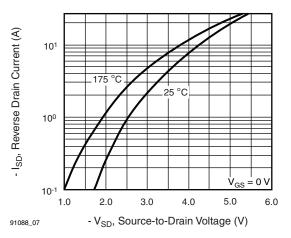


Fig. 7 - Typical Source-Drain Diode Forward Voltage

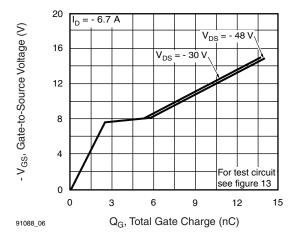


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

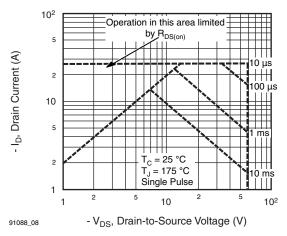


Fig. 8 - Maximum Safe Operating Area



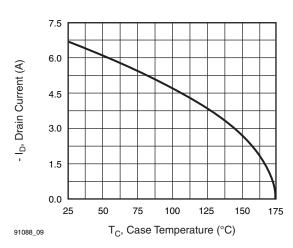


Fig. 9 - Maximum Drain Current vs. Case Temperature

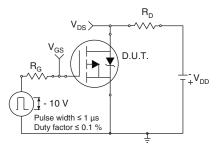


Fig. 10a - Switching Time Test Circuit

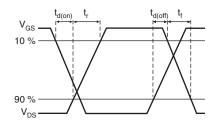


Fig. 10b - Switching Time Waveforms

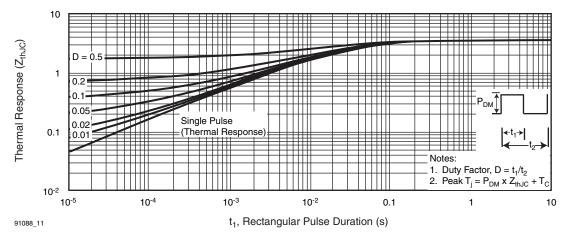


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



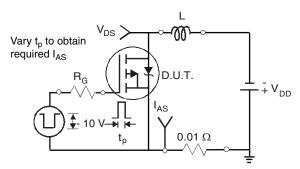


Fig. 12a - Unclamped Inductive Test Circuit

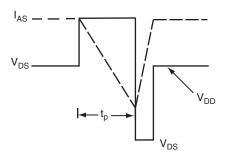


Fig. 12b - Unclamped Inductive Waveforms

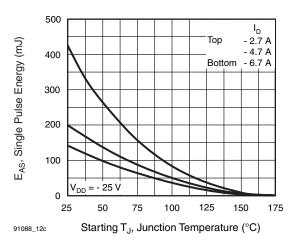


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

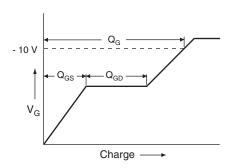


Fig. 13a - Basic Gate Charge Waveform

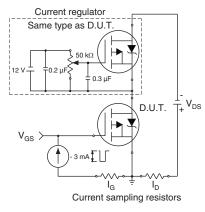
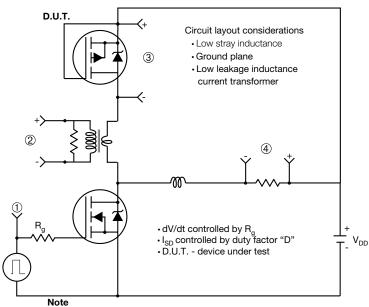


Fig. 13b - Gate Charge Test Circuit

Peak Diode Recovery dV/dt Test Circuit



· Compliment N-Channel of D.U.T. for driver

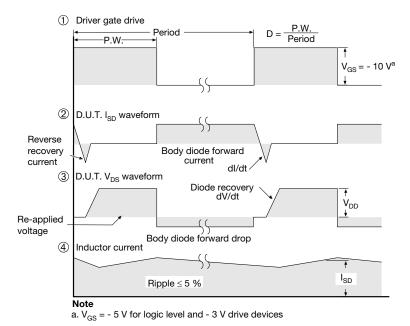


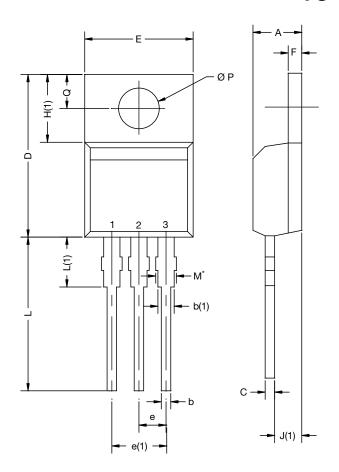
Fig. 14 - For P-Channel

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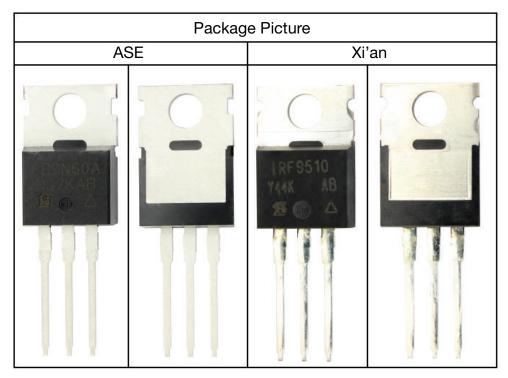
TO-220-1



DIM.	MILLIM	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.24	4.65	0.167	0.183		
b	0.69	1.02	0.027	0.040		
b(1)	1.14	1.78	0.045	0.070		
С	0.36	0.61	0.014	0.024		
D	14.33	15.85	0.564	0.624		
Е	9.96	10.52	0.392	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.10	6.71	0.240	0.264		
J(1)	2.41	2.92	0.095	0.115		
L	13.36	14.40	0.526	0.567		
L(1)	3.33	4.04	0.131	0.159		
ØР	3.53	3.94	0.139	0.155		
Q	2.54	3.00	0.100	0.118		
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031						

Note

 M* = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542



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